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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Application Number	09/995,222
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				First Named Inventor	Langemyr et al.
				Art Unit	2121
				Examiner Name	To Be Assigned
Sheet	1	of	1	Attorney Docket Number	801939/111

U.S. PATENT DOCUMENTS					
Examiner Initials ¹	Cite No. ¹	U.S. Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS						
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials ¹	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
Agul	1	George et al., "Delaunay Triangulation and Meshing," <i>Hermes</i> , Paris 33-238 (1998)	
		Delaunay triangulation: 33-46, 50-59; Constrained triangulation: 73-99;	
		Parametric surface meshing: 161-173; Optimizations: 215-238	
Agul	2	Dahlquist, et al., "Numerical Methods," <i>Prentice Hall</i> 284-355 (1974)	
		Interpolation: 284-285; Linear Solver: 146-172; Time-Dependent Solver: 347-355;	
		Eigenvalue Solver: 208-211; Damped Newton Method: 248-253	
Agul	3	Brenner et al., "The Mathematical Theory of Finite Element Methods," <i>Springer-Verlag</i>	
		1-12 (1994) The Finite Element Method: 1-12	
Agul	4	Frey et al., "Mesh Generation, Application to Finite Elements," <i>Hermes</i> , Paris 88-90	
		(2000) Mesh Search: 88-90	
Agul	5	Zienkiewicz et al., "The Finite Element Method," <i>McGraw-Hill</i> 1:23-177	
		Basis Function: 23-26; Quadrature Formulas, Gauss Points, Weights: 175-177	
Agul	6	Davenport et al., "Computer Algebra Systems and Algorithms for Algebraic	
		Computation," <i>Academic Press</i> 28-32 (1993) Symbolic Differentiation: 28-32	
Agul	7	C. Johnson, "Numerical Solution of Partial Differential Equations by the Finite Element	
		Method," <i>Studentlitteratur</i> 14-18 (1987) Test Function 14-18	

Examiner Signature	Agul Swanson	Date Considered	1/18/06
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